	Notice	of Re	ferences	Cited
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Application/Control No. 10/574,735	Reexamination	Applicant(s)/Patent Under Reexamination OESTERLE ET AL.		
Examiner	Art Unit			
Scott Haudland	3654	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,820,058 A	10-1998	Hirzel et al.	242/379.1
*	В	US-5,938,135 A	08-1999	Sasaki et al.	242/374
*	С	US-6,012,667 A	01-2000	Clancy et al.	242/379.1
*	D	US-6,206,315 B1	03-2001	Wier	242/379.1
*	Е	US-6,216,972 B1	04-2001	Rohrle	242/379.1
*	F	US-6,416,006 B1	07-2002	Huber	242/379.1
*	G	US-6,416,007 B1	07-2002	Stegmeier	242/379.1
*	Н	US-6,431,531 B1	08-2002	Yu et al.	267/154
*	1	US-6,616,081 B1	09-2003	Clute et al.	242/379.1
	J	US-			
	к	US-			
	٦	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

	NON-FATENT DOCUMENTS				
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	v				
	w				
	×				

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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